Search Notes				

Application/Control No.	Applicant(s)/Patent und r R xamination
10/606,477	GHOMESHI ET AL.
Examiner	Art Unit
Tuan D. Nguyen	2614

	SEAR	CHED	-
Class	Subclass	Date	Examiner
379	421	8/2/2006	TN
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	202.01		
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381	94.5	8/3/2006	
	104	1	
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455	567		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Jack Chiang	8/2/2006	TN
Duc Nguyen	8/3/2006	TN
<u>.</u> .		